







an Open Access Journal by MDPI

Tomography Sensing Technologies

Guest Editor:

Prof. Dr. Manuchehr Soleimani EEE Department, University of

EEE Department, University of Bath, Bath BA1 8BE, UK

Deadline for manuscript submissions:

closed (30 January 2021)

Message from the Guest Editor

Dear Colleagues,

This Special Issue is aiming at international, multidisciplinary studies devoted to all areas of tomographic imaging. The areas of interest include but are not limited to:

- Industrial applications both for process monitoring and material characterization, and nondestructive testing;
- Environmental and geophysical tomography;
- Biological and biomedical tomography;
- Tomography and control.

Areas of interest include all aspects of tomographic imaging, including computational and mathematical aspects, tomographic instrument and sensors, underlying physics, data interpretation and applications, use of tomography in control, and tomography in soft sensors and robotics.

For further information about the topics of interest, please visit:

https://www.mdpi.com/journal/sensors/special_issues/tst

Prof. Dr. Manuchehr Soleimani Guest Editor













an Open Access Journal by MDPI

Editor-in-Chief

Prof. Dr. Vittorio M. N. Passaro

Dipartimento di Ingegneria Elettrica e dell'Informazione (Department of Electrical and Information Engineering), Politecnico di Bari, Via Edoardo Orabona n. 4, 70125 Bari, Italy

Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

Author Benefits

Open Access: free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility: indexed within Scopus, SCIE (Web of Science), PubMed, MEDLINE, PMC, Ei Compendex, Inspec, Astrophysics Data System, and other databases. **Journal Rank:** JCR - Q2 (*Instruments & Instrumentation*) / CiteScore - Q1

(Instrumentation)

Contact Us